Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/662,066	BUI, QUY DUC
Examiner	Art Unit
Christopher S. Kim	3752

	SEAR	CHED	
	1	<u> </u>	Ι
Class	Subclass	Date	Examiner
239	533.14 519 513 502-504 516 546		
	576 533.13	9/2/2005	ск

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	10		
	·		

(INCLUDING SE	CH NOTES ARCH STRATEGY	()
	DATE	EXMR
		<u> </u>
		-
		-
		i